



# 20N50P

## 20A 500V N-Channel Enhancement Mode Power MOSFET

### General Description

These Silicon N-channel enhanced vdmofets, is obtained by the self-aligned planar used technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. Which accords with the RoHS standard.

### Features

- Fast switching
- Low on-resistance
- Low gate charge
- 100% avalanche tested

### Mechanical Data

- Case:TO-247 Package

### Application

- Switching applications

### Ordering Information

Part No.	Package Type	Package	Quality(box)
20N50P	TO-247	Tube	360

Product Summary			
V <sub>DS</sub>	R <sub>DS(on)</sub> (Ω) Typ	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ)
500V	0.24@10V	20	52nc

TO-247

20N50P



### Block Diagram

Pin Definition:

1. Gate
2. Drain
3. Source

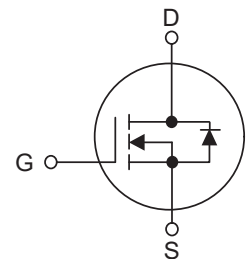


Table1 Absolute Maximum Ratings (T<sub>C</sub>=25 °C , unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	500	V
Gate-Source Voltage	V <sub>GS</sub>	±30	V
Continuous Drain Current	I <sub>D</sub>	T <sub>C</sub> =25°C	20
		T <sub>C</sub> =100°C	12.5
Pulsed Drain Current (Note 1)	I <sub>DM</sub>	80	A
Single Pulse Avalanche Energy(Note 2)	E <sub>AS</sub>	1300	mJ
Peak Diode Recovery dv/dt	dv/dt	5	V/ns
Power Dissipation T <sub>C</sub> =25°C	P <sub>D</sub>	277	W
Operating Junction and Storage Temperature	T <sub>J</sub> /T <sub>STG</sub>	-55 ~ +150	°C
Maximum Temperature for soldering	T <sub>L</sub>	300	°C

Table 2. Thermal Characteristics

Parameter	Symbol	TO-247	Unit
Thermal resistance Junction to Ambient	$R_{\theta JA}$	62.5	C/W
Thermal resistance Junction to Case	$R_{\theta JC}$	0.45	C/W

 Table 3. Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	500			V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=500V, V_{GS}=0V$			1	$\mu A$
Gate- Source Leakage Current	Forward	$V_{GS}=30V, V_{DS}=0V$			100	nA
	Reverse	$V_{GS}=-30V, V_{DS}=0V$			-100	nA
On Characteristics(Note 4)						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2		4	V
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=10A$		0.24	0.3	$\Omega$
Dynamic Characteristics(Note 5)						
Input Capacitance	$C_{ISS}$	$V_{DS}=25V, V_{GS}=0V, f=1\text{MHz}$		2919		pF
Output Capacitance	$C_{OSS}$			277		pF
Reverse Transfer Capacitance	$C_{RSS}$			16		pF
Switching Characteristics (Note 5)						
Turn-On Delay Time	$t_d(\text{on})$	$V_{DD}=250V, I_D=20A,$ $R_G=10\Omega$		34		ns
Turn-On Rise Time	$t_R$			65		ns
Turn-Off Delay Time	$t_d(\text{off})$			82		ns
Turn-Off Fall Time	$t_f$			45		ns
Total Gate Charge	$Q_G$	$V_{DD}=400V, I_D=20A,$ $V_{GS}=10V$		52		nC
Gate-Source Charge	$Q_{GS}$			12.6		nC
Gate-Drain Charge	$Q_{GD}$			18.6		nC
Drain-Source Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_S=20A$			1.5	V
Maximum Continuous Drain-Source Diode Forward Current	$I_S$				20	A
Reverse Recovery Time	$t_{rr}$	$V_{GS}=0V, I_S=20A$		535		ns
Reverse Recovery Charge	$Q_{RR}$	$di/dt=100A/\mu s$		75		nC

Notes : 1 Repetitive Rating:Pulse width limited by maximum junction temperature

 2  $L=10\text{mH}, I_D=16.1\text{A}, \text{Starting } T_J=25^\circ\text{C}$ 

 4 Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ 

5 Guaranteed by design, not subject to production

Typical Characteristics Diagrams

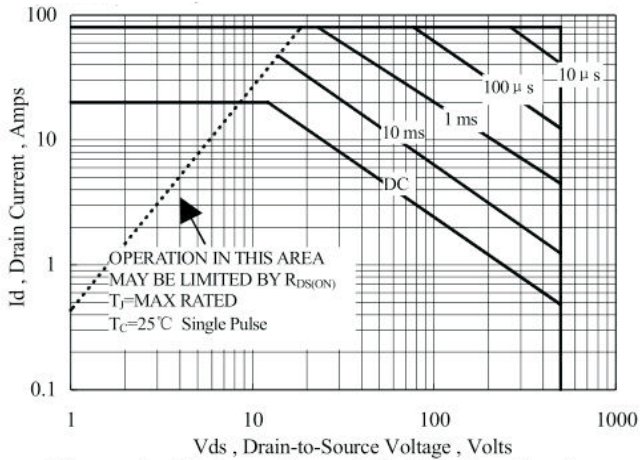


Figure 1 Maximum Forward Bias Safe Operating Area

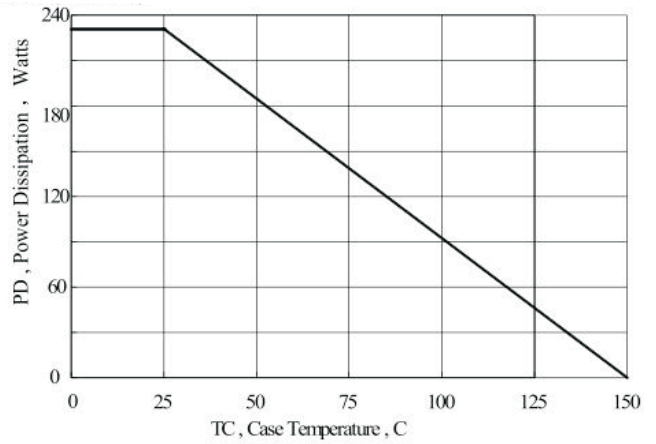


Figure 2 Maximum Power Dissipation vs Case Temperature

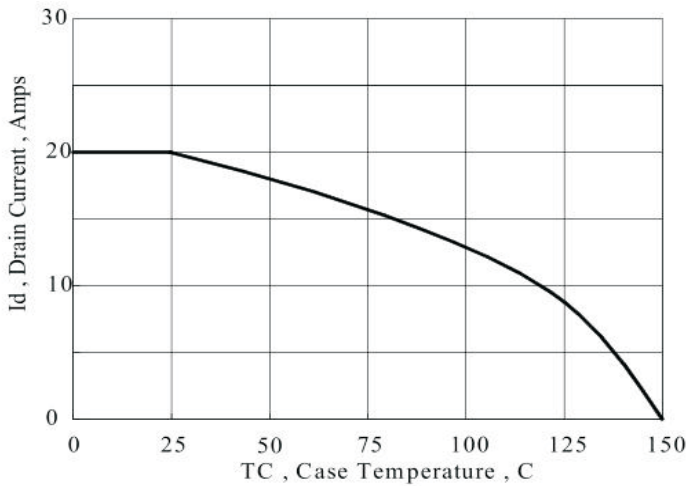


Figure 3 Maximum Continuous Drain Current vs Case Temperature

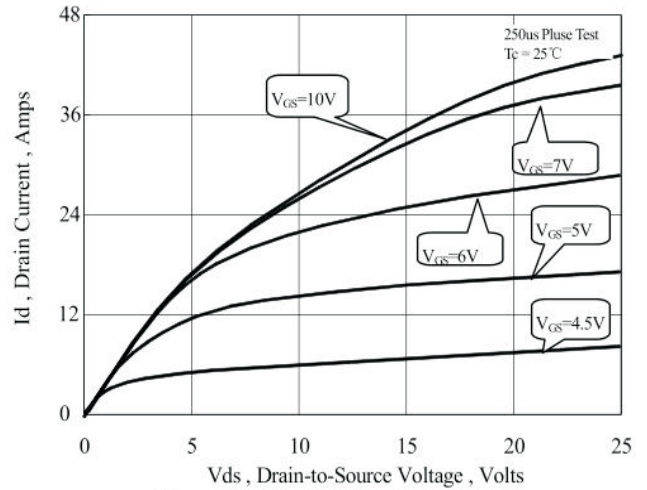


Figure 4 Typical Output Characteristics

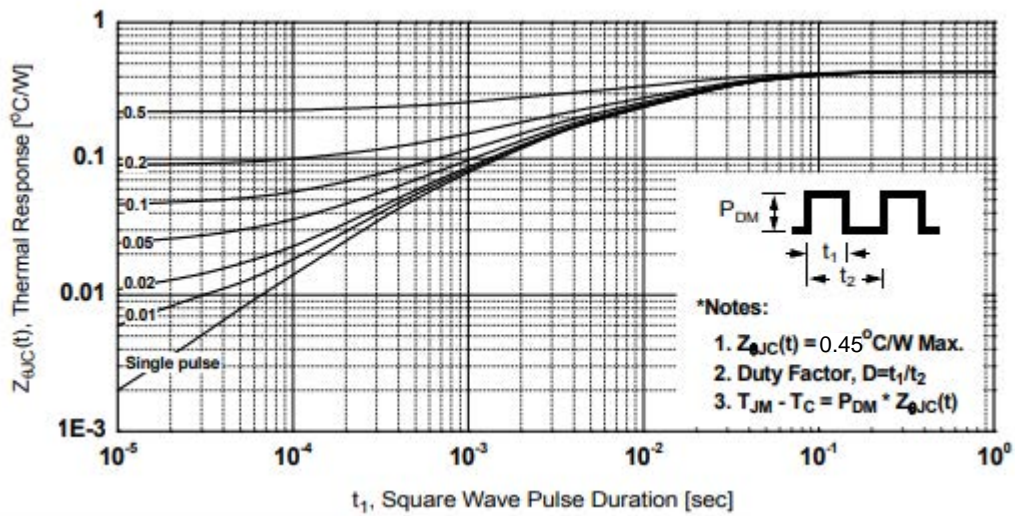


Figure 5 Maximum Effective Thermal Impedance, Junction to Case

Typical Characteristics Diagrams

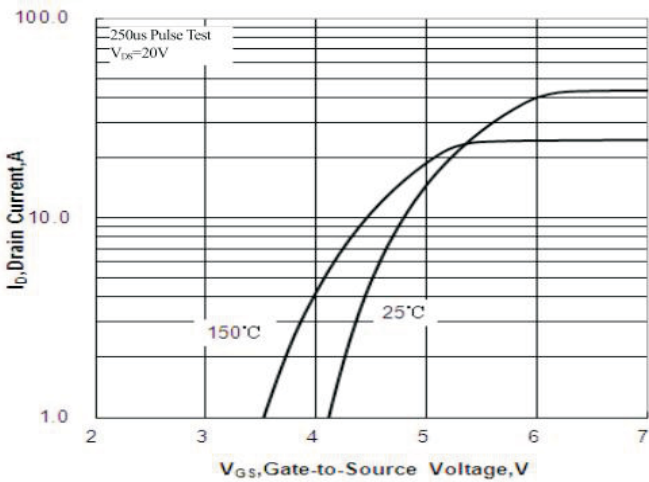


Figure 6 Typical Transfer Characteristics

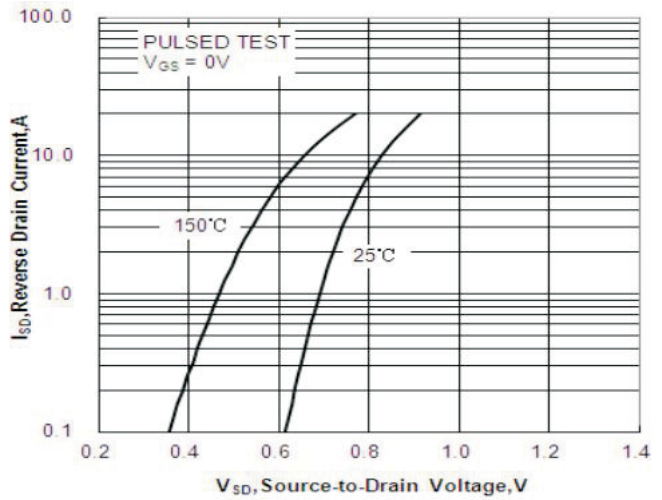


Figure 7 Typical Body Diode Transfer Characteristics

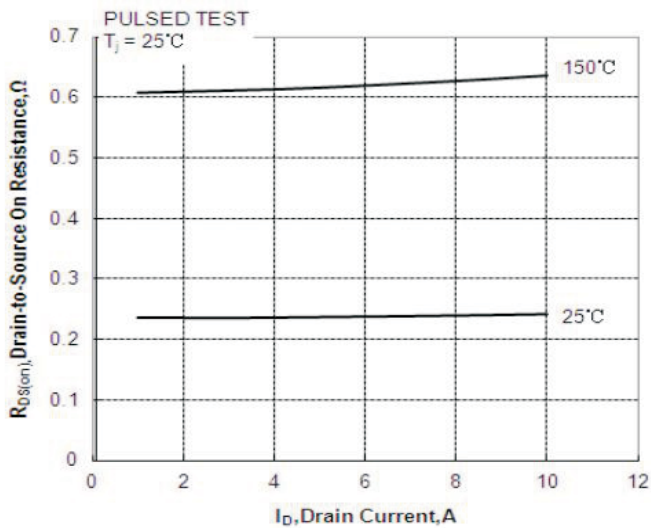


Figure 8 Typical Drain to Source ON Resistance vs Drain Current

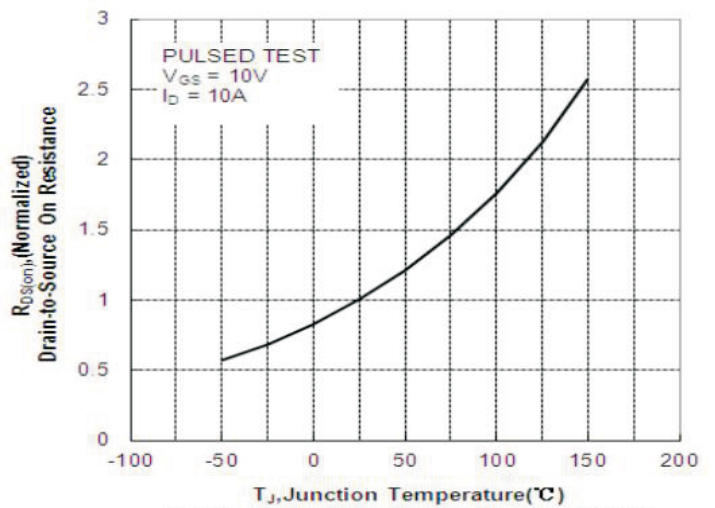


Figure 9 Typical Drain to Source on Resistance vs Junction Temperature

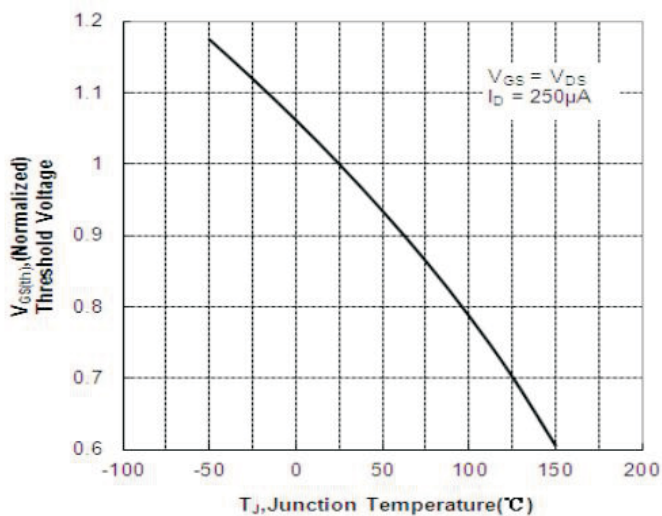


Figure 10 Typical Theshold Voltage vs Junction Temperature

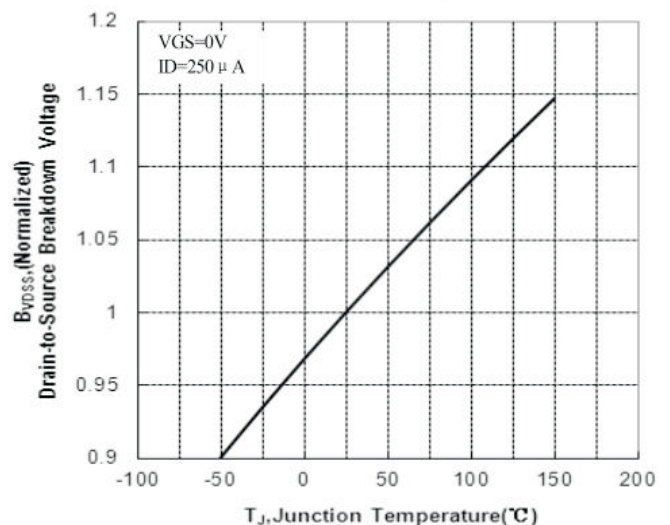


Figure 11 Typical Breakdown Voltage vs Junction Temperature



Typical Characteristics Diagrams

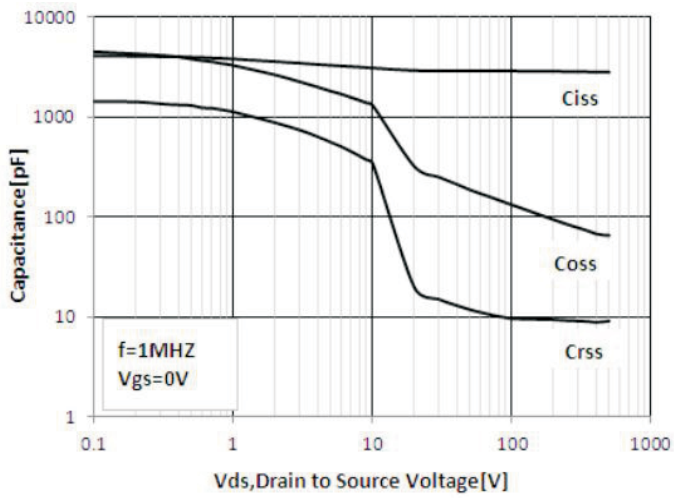


Figure 12 Typical Capacitance vs Drain to Source Voltage

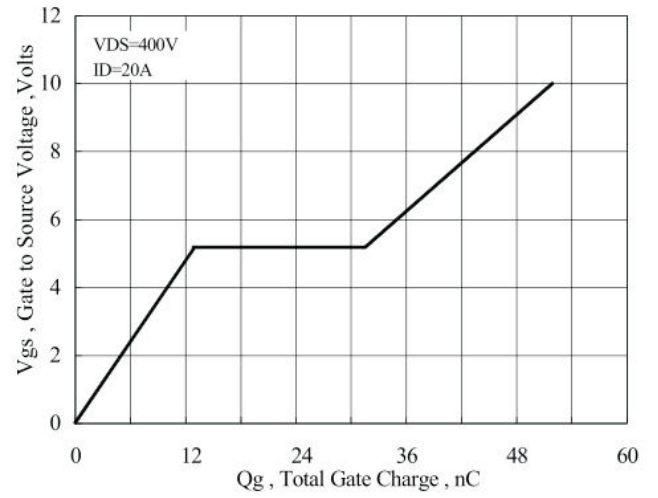
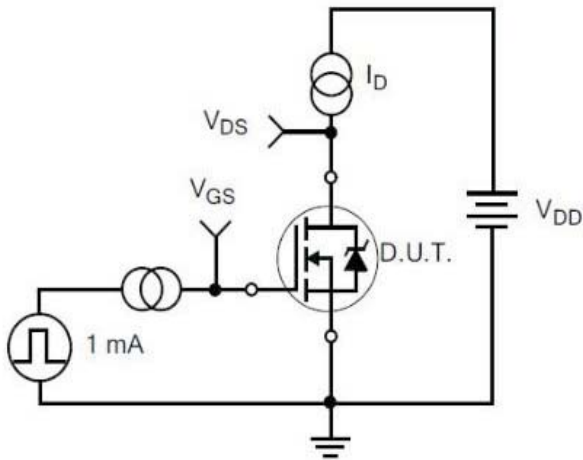
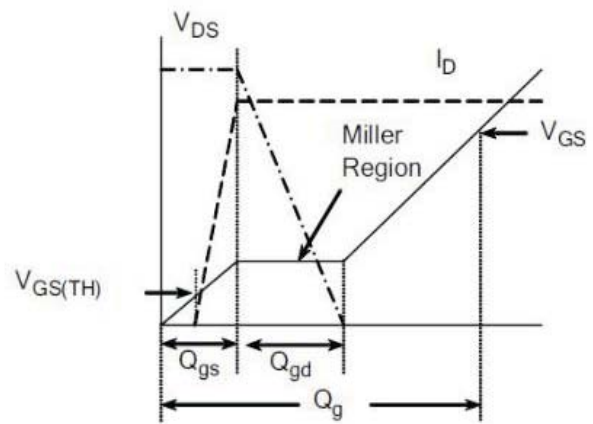


Figure 13 Typical Gate Charge vs Gate to Source Voltage

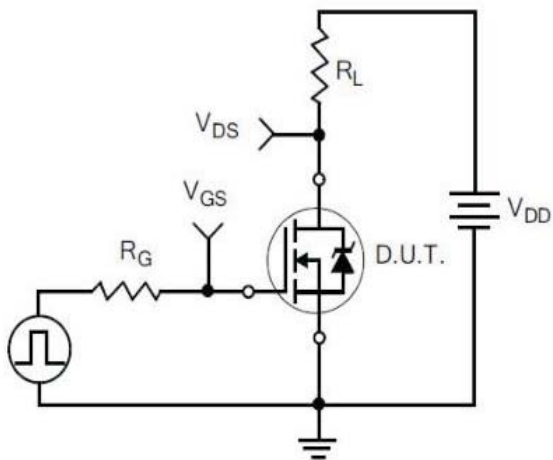
## Typical Test Circuit



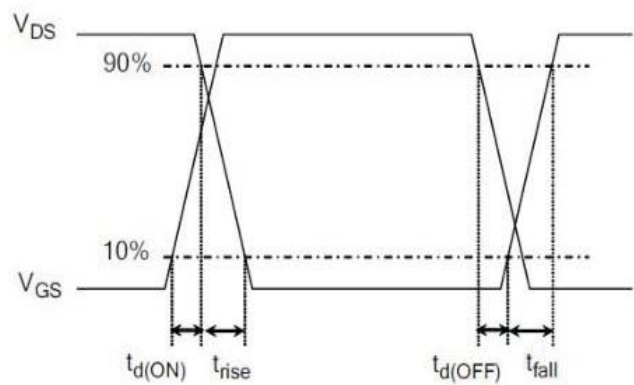
1) Gate Charge Test Circuit



2) Gate Charge Waveform

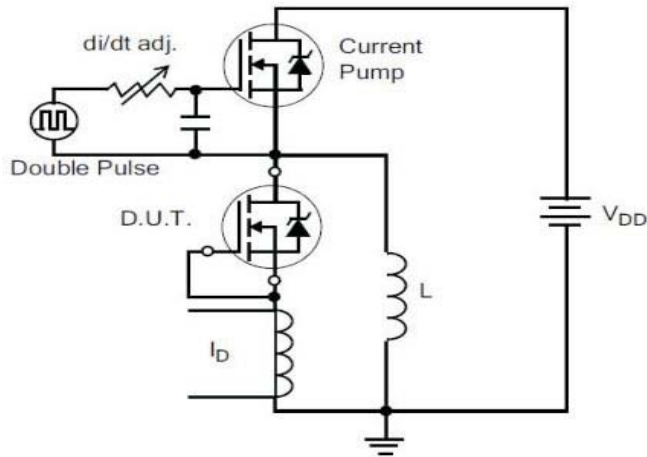


3) Resistive Switching Test Circuit

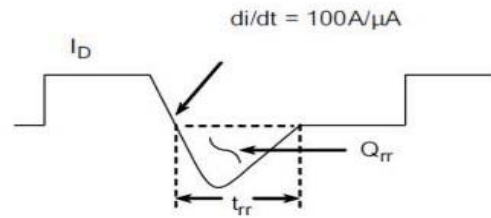


4) Resistive Switching Waveforms

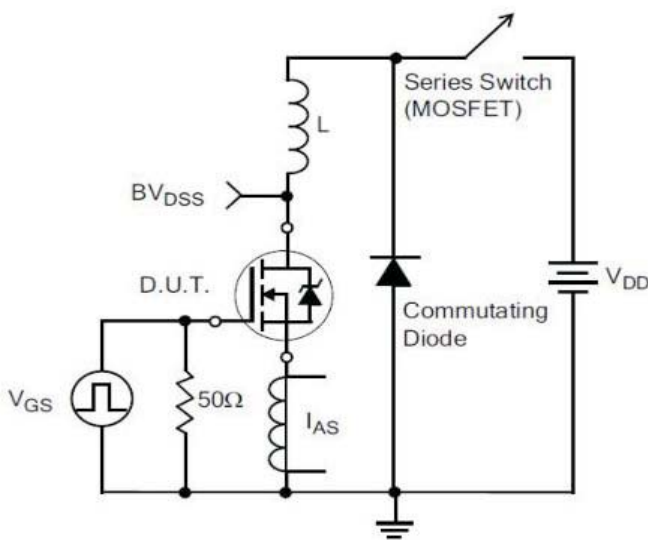
## Typical Test Circuit



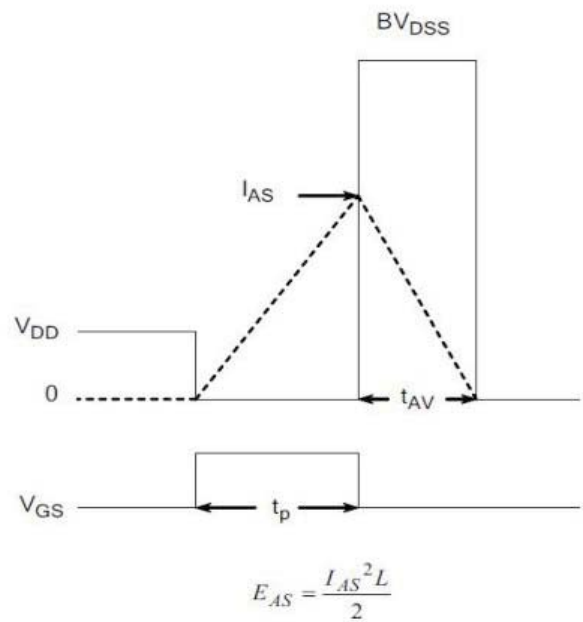
5) Diode Reverse Recovery Test Circuit



6) Diode Reverse Recovery Waveform

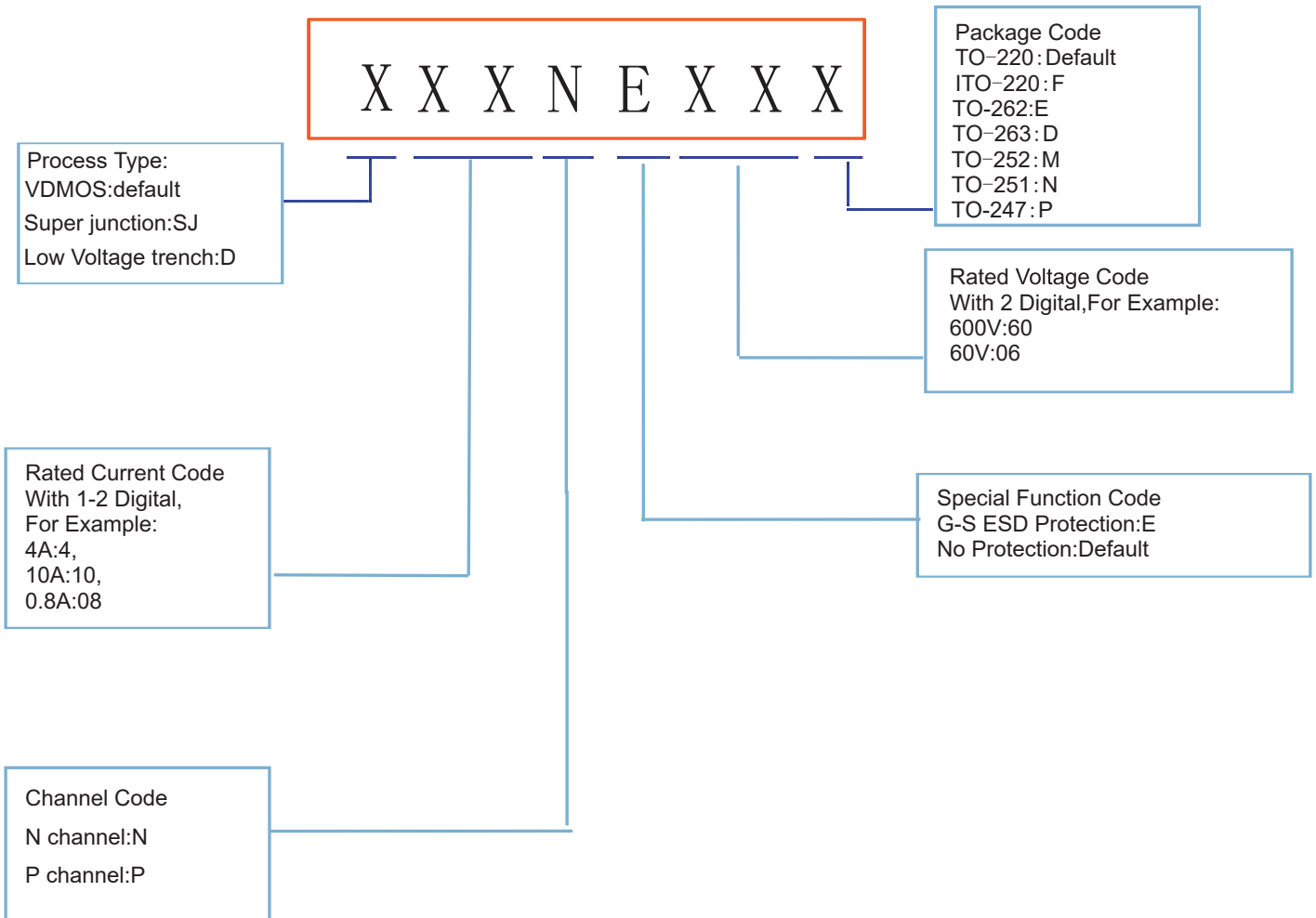


7) . Unclamped Inductive Switching Test Circuit



8) Unclamped Inductive Switching Waveforms

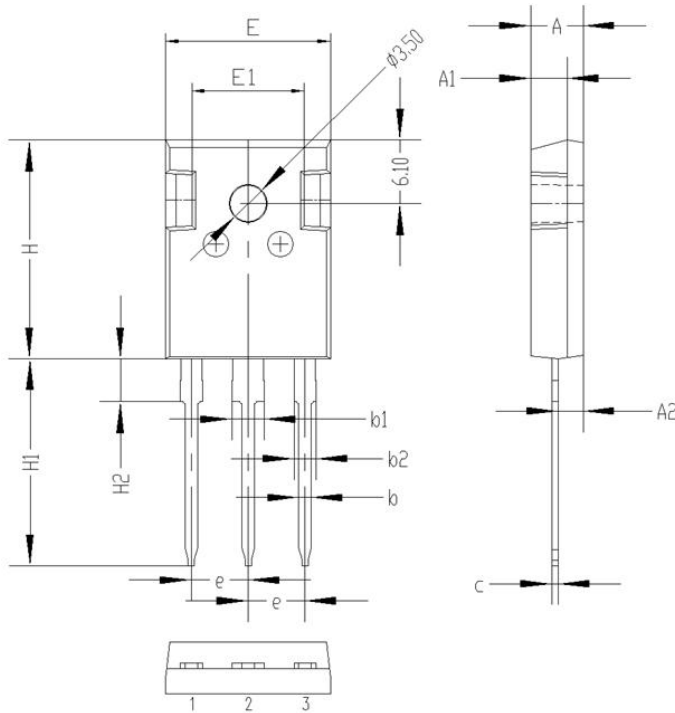
Product Names Rules





## Dimensions

## TO-247 PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions(millimeters)	
	Min.	Max.
A	4.80	5.20
A1	3.30	3.70
A2	2.10	2.50
b	1.00	1.40
b1	2.90	3.30
b2	1.90	2.30
c	0.40	0.80
e	5.25	5.65
E	15.6	16.0
E1	10.6	11.00
H	20.8	21.2
H1	19.4	20.4
H2	3.90	4.30
G	5.90	6.30
ΦP	3.30	3.70

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